

# AGD-310D

## Environment Test Report

Report NO: 11P020018

|         |   |
|---------|---|
| Summary | <p><input checked="" type="checkbox"/> <b>Pass</b></p> <p><input type="checkbox"/> <b>Fail</b></p> <p>Note : There is/are ____ defect(s) not list in the report, please check it in the DTS Website.</p> <p><input type="checkbox"/> <b>Pass with Deviation</b></p> <p>Comment: _____</p> |
|---------|---|

Issue date

2011-07-11

Approval

Jansin Lee

Test Engineer

Rex Chang

# Test item list

|  |    |
|--|----|
| 1. <i>Test item list</i> -----                       | 2  |
| 2. <i>Configuration of EUT</i> -----                 | 3  |
| 2. <i>Temperature rise test</i> -----                | 4  |
| 3. <i>Temperature variation operation test</i> ----- | 6  |
| 4. <i>High temperature storage test</i> -----        | 7  |
| 5. <i>Low temperature storage test</i> -----         | 8  |
| 6. <i>Humidity test</i> -----                        | 9  |
| 7. <i>Cold start and hot start test</i> -----        | 10 |

## Testing Result

| Num | Test item list                       | Result | Remark |
|-----|--------------------------------------|--------|--------|
| 1   | Temperature rise test                | Pass   |        |
| 2   | Temperature variation operation test | Pass   |        |
| 3   | High temperature storage test        | Pass   |        |
| 4   | Low temperature storage test         | Pass   |        |
| 5   | Humidity test                        | Pass   |        |
| 6   | Cold start and hot start test        | Pass   |        |

# Configuration of EUT

---

| Num | Item                          | Spec   |
|-----|-------------------------------|--|
| 1.  | Rugged Touch Display          | AGP-310D   |
|     | 1. LCD                        | 10.4".AUO.G104SN02 V2 800*600 400nits            |
|     | 2. Touch Screen Control Board | EETI control board (USB/RS232 auto-detect board) |
|     | 3. A/D Board                  | S2555L-011                                       |
| 2.  | Adapter                       | FSP FSP060-DBAB1                                 |
| 3.  | System PC Model               | AEC-6625 A0.2                                    |
|     | 1. Main Board                 | EPIC-QM57 A1.0                                   |
|     | 6. BIOS Ver.                  | AEC-6625 1.0(01/06/2011)                         |

# Temperature rise test

**Test Date:** 07-08-2011

**Test Product:** AGD-310D

**Test Site:** AAEON QE Internal Lab.

**Test Standard:** Reference EN 61131-2(94), UL508 (94)

**Temperature Measurement:**

40 Channel Thermal Recorder:

YOKOGAWA Inc,

Model: DA100-13-1D

Date of Calibration: 11/08/10

Serial Number: 12A323190

**Test Condition:**

Ambient temperature: 55°C

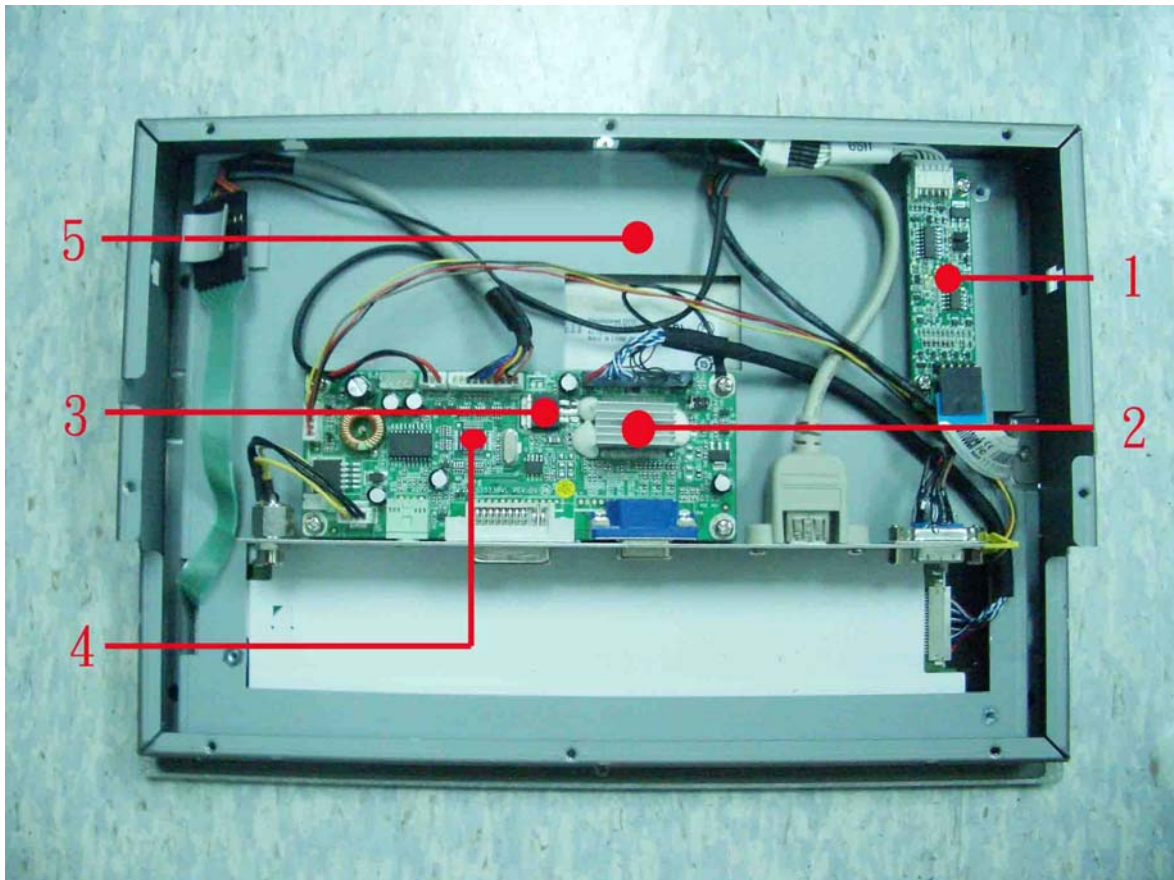
Continuous running till thermal stability (within less than 1°C)

**Test Software:**

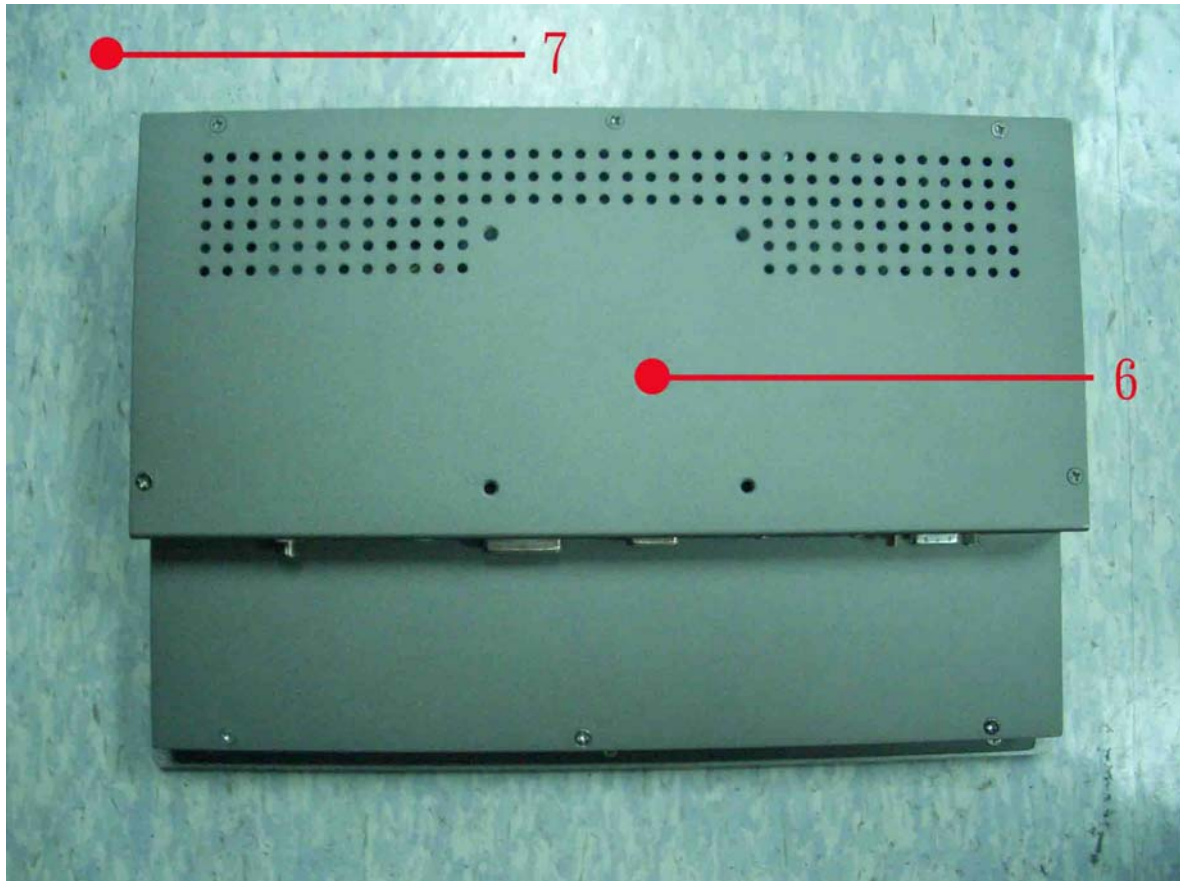
Windows XP / Run 3DMark06 Professional Edition 1.2.0

**Terminal Recorder:**

Measuring Thermal Couple Position :



# Temperature rise test



## Thermal profile data:

### AGD-310D

| Point  | Temp. Stage(°C) | Spec | 55   | 25   |
|--|-----------------|------|------|------|
| <b>Touch Screen Control Board</b>  |                 |      |      |      |
| 01. U4 – EETI S458XRUP   |                 | 85   | 68.8 | 38.8 |
| <b>S2555L-011 AD Board</b>   |                 |      |      |      |
| 02. U6 - REALTEK RTD2555LH   |                 | 85   | 77.5 | 47.5 |
| 03. U5 - AIC 1084-33GM   |                 | 100  | 78.7 | 48.7 |
| 04. U4 - REALTEK RTD2120L A6M2002  |                 | 85   | 73.2 | 43.2 |
| 05. Control Box Inside Air Temperature   |                 | N/A  | 65.5 | 35.5 |
| 06. Control Box External Surface   |                 | N/A  | 62.3 | 32.3 |
| 07. Chamber Air Temperature  |                 | N/A  | 55.0 | 25.0 |
| <b>Any Tm value showed in red words which meaning the value over the Tc degree C of this device specification.</b> |                 |      |      |      |

## Sample Configuration & Quantity Under Test:

Quantity: 1 (AGD-310D)

## Test Result:

No problem was found during the temperature rise operation test.

# Temperature variation operation test

**Test Date:** 07-05~07-2011

**Test Product:** AGD-310D

**Test Site:** AAEON QE Internal Lab.

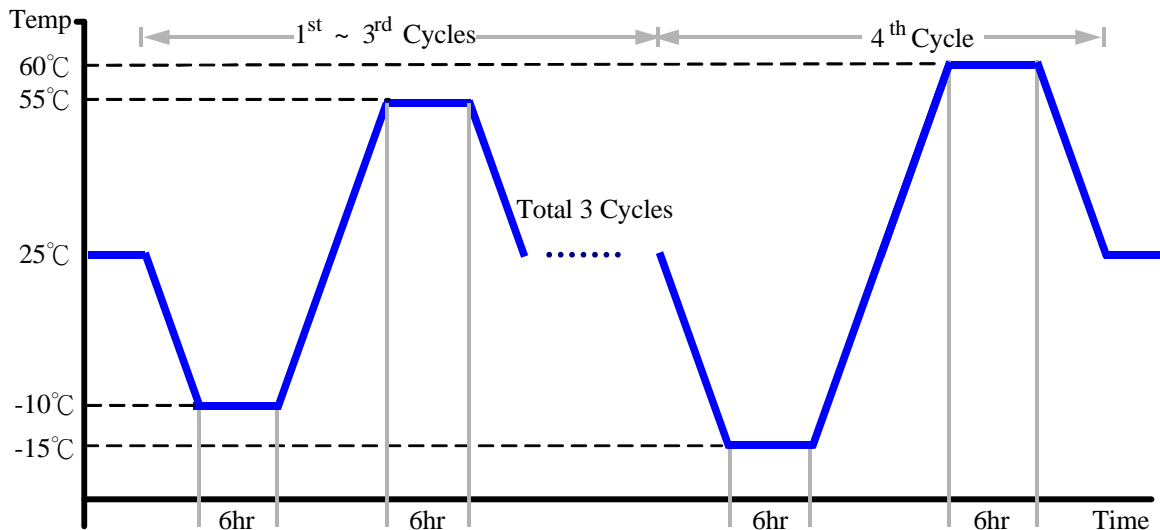
**Test Standard:** Reference IEC68-2-14 Testing procedures  
Test N: Change of temperature Test

**Test Equipment:**

Programmable Temperature & Humidity Chamber  
K.SON. INS. TECH. CORP.  
Model: THS-D7S-100+1 N2  
Date of Calibration: 12/01/10  
Serial Number: 3898

**Test Condition:**

1. Test Low Temperature: -10°C (1~3 cycles)  
-15°C (4<sup>th</sup> cycle)
2. Test High Temperature: 55°C (1~3 cycles)  
60°C (4<sup>th</sup> cycle)
3. Test dwell time: 6Hrs
4. Temperature slope: 2°C/min
5. Test cycle: 4 cycles
6. Test Software: Windows XP / Run 3DMark06 Professional Edition 1.2.0
7. Test Environment Curve:



**Sample Configuration & Quantity Under Test:**

Quantity: 1 (AGD-310D)

**Test Result:**

No problem was found during the temperature operation cycle test.

# High temperature storage test

**Test Date:** 06-27~29-2011

**Test Product:** AGD-310D

**Test Site:** AAEON QE Internal Lab.

**Test Standard:** Reference IEC 68-2-2 Testing procedures  
Test Bb: Dry Heat Test (Non-operation)

**Test Equipment:**

Programmable Temperature & Humidity Chamber  
K.SON. INS. TECH. CORP.  
Model: THS-D7S-100+1 N2  
Date of Calibration: 12/01/10  
Serial Number: 3898

**Testing Item:**

1. Test Temperature: 70°C
2. Test Times: 48Hrs
3. Test Software: Windows XP / Run PassMark Burn In Test 6.0 Pro
4. Test Environment Curve:



**Sample Configuration & Quantity Under Test:**

Quantity: 1 (AGD-310D)

**Test Result:**

No problem was found after the high temperature storage test.

# Low temperature storage test

---

**Test Date:** 06-29-2011 ~ 07-01-2011

**Test Product:** AGD-310D

**Test Site:** AAEON QE Internal Lab.

**Test Standard:** Reference IEC 68-2-1 Testing procedures  
Test Ab: Cold Test (Non-operation)

**Test Equipment:**

Programmable Temperature & Humidity Chamber  
K.SON. INS. TECH. CORP.

Model: THS-D7S-100+1 N2

Date of Calibration: 12/01/10

Serial Number: 3898

**Testing Item:**

1. Test Temperature: -20°C
2. Test Times: 48Hrs
3. Test Software: Windows XP / Run PassMark Burn In Test 6.0 Pro
4. Test Environment Curve:



**Sample Configuration & Quantity Under Test:**

Quantity: 1 (AGD-310D)

**Test Result:**

No problem was found after the low temperature storage test.



# Humidity test

**Test Date:** 07-01~03-2011

**Test Product:** AGD-310D

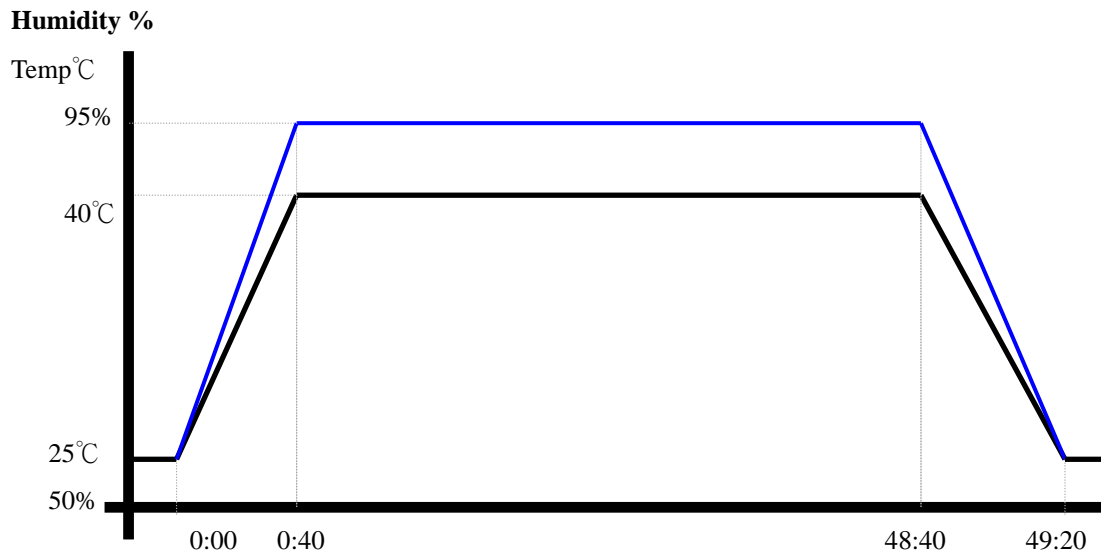
**Test Site:** AAEON QE Internal Lab.

**Test Standard:** Reference IEC 68-2-3 Testing procedures  
Test Ca: Damp heat, steady state (Non-operation)

**Test Equipment:**  
Programmable Temperature & Humidity Chamber  
K.SON. INS. TECH. CORP.  
Model: THS-D7S-100+1 N2  
Date of Calibration: 12/01/10  
Serial Number: 3898

**Testing Item:**

1. Test Temperature: 40°C
2. Test Humidity: 95%RH
3. Test Times: 48Hrs
4. Test Software: Windows XP / Run PassMark Burn In Test 6.0 Pro
5. Test Environment Curve:



**Sample Configuration & Quantity Under Test:**

Quantity: 1 (AGD-310D)

**Test Result:**

No problem was found after the humidity storage test.

# Cold start and hot start test

**Test Date:** 07-04~05-2011

**Test Product:** AGD-310D

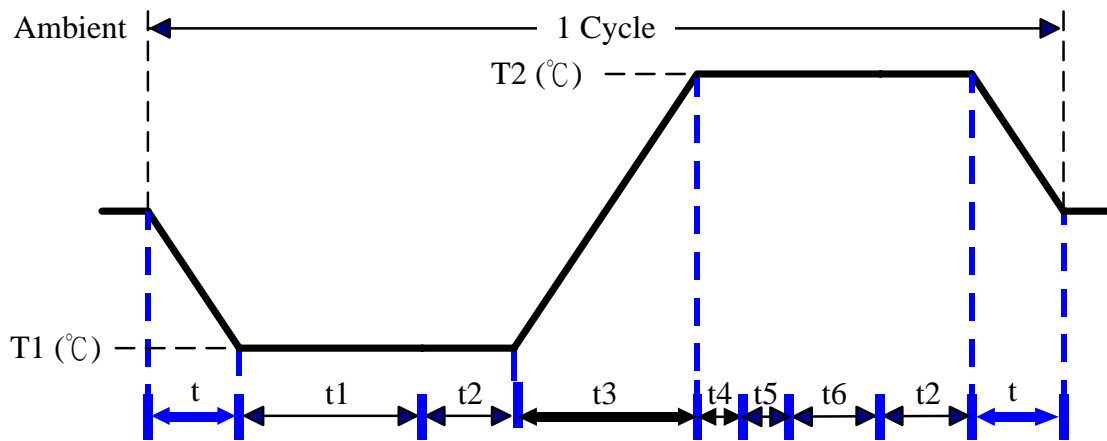
**Test Site:** AAEON QE Internal Lab.

**Test Standard:** Reference IEC 68-2-14 Testing procedures  
Test N: Change of temperature Test

**Test Equipment:**

Programmable Temperature & Humidity Chamber  
K.SON. INS. TECH. CORP.  
Model: THS-D7S-100+1 N2  
Date of Calibration: 12/01/10  
Serial Number: 3898

**Test Condition:**



| Parameters | Description |
|------------|-------------|
| T1         | -15°C       |
| T2         | 60°C        |
| t1         | 4 hrs       |
| t2, t6     | 2 hrs       |
| t4, t5     | 1hrs        |
| t, t3      | 2°C/min     |
| n (Cycle)  | 1           |

t = temperature slope  
t , t1, t6: Power Off  
t2: Power on/off test 10 times (on 2 min / off 5min)  
t3, t4: Run PassMark Burn In Test  
t5: Windows XP Software restart test 3 times  
Test Software: Windows XP

**Test Result:**

- a. No problem was found during the cold start test.
- b. No problem was found during the hot start test.